LE25S80FD

Advance Information

CMOS LSI 8M-bit (1024K × 8) Serial Flash Memory

Overview

The LE25S80FD is a SPI bus flash memory device with a 8M bit ($1024K \times 8$ -bit) configuration that adds a high performance Dual output and Dual I/O function. It uses a single 1.8V power supply. While making the most of the features inherent to a serial flash memory device, the LE25S80FD is housed in an 8-pin ultra-miniature package. All these features make this device ideally suited to storing program in applications such as portable information devices, which are required to have increasingly more compact dimensions. The LE25S80FD also has a small sector erase capability which makes the device ideal for storing parameters or data that have fewer rewrite cycles and conventional EEPROMs cannot handle due to insufficient capacity.

Function

- Read/write operations enabled by single 1.8V power supply : 1.65 to 1.95V supply voltage range
- Operating frequency : 40MHz
- Temperature range : -40 to +90°C
- Serial interface : SPI mode 0, mode 3 supported
- Sector size : 4K bytes/small sector, 64K bytes/sector
- Small sector erase, sector erase, chip erase functions
- Page program function (256 bytes / page)
- Block protect function

• Status functions

Package

- Data retention period : 20 years
 - : Ready/busy information, protect information
- Highly reliable read/write Number of rewrite times Small sector erase time Sector erase time Chip erase time
- : 80ms (typ.), 250ms (max.)

: 40ms (typ.), 150ms (max.)

: 100.000 times

- : 500ms (typ.), 6.0s (max.)
- Page program time
- : 0.8ms/256 bytes (typ.), 1.0ms/256 bytes (max.) : VSOIC8 NB, CASE 753AA

VSOIC8 NB

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This document contains information on a new product. Specifications and information herein are subject to change without notice

ORDERING INFORMATION

See detailed ordering and shipping information on page 23 of this data sheet.



Specifications

Absolute Maximum Ratings at $Ta = 25^{\circ}C$

Parameter	Symbol	Conditions	Ratings	unit
Maximum supply voltage		With respect to V _{SS}	-0.5 to +2.4	V
DC voltage (all pins)		With respect to V _{SS}	-0.5 to V _{DD} +0.5	V
Storage temperature	Tstg		-55 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Recommended Operating Conditions

Parameter	Symbol	Conditions	Ratings	unit
Operating supply voltage			1.65 to 1.95	V
Operating ambient temperature			-40 to +90	°C

Allowable DC Operating Conditions

Devenueter	Querrahael	umbol Conditions			Ratings			it
Parameter	Symbol	Conditions	Conditions		min	typ	max	unit
		$SCK = 0.1V_{DD}/0.9V_{DD},$	0.1	33MHz			6	mA
Read mode operating current	ICCR	$\overline{\text{HOLD}} = \overline{\text{WP}} = 0.9 \text{V}_{\text{DD}},$	Single	40MHz			8	mA
		SO = open	Dual	40MHz			10	mA
Write mode operating current (erase+page program)	Iccw	t _{SSE} = t _{SE} = t _{CHE} = typ., t _{PP} =	tSSE = tSE = tCHE = typ., tpp = max				15	mA
CMOS standby current	I _{SB}	$\overline{CS} = V_{DD}, \overline{HOLD} = \overline{WP} = V_{DD},$ SI = $V_{SS}/V_{DD}, SO = open$					50	μΑ
Power-down standby current	IDSB	$\overline{CS} = V_{DD}$, $\overline{HOLD} = \overline{WP} = V_{DD}$, SI = V_{SS}/V_{DD} , SO = open					15	μΑ
Input leakage current	ILI						2	μA
Output leakage current	ILO						2	μA
Input low voltage	VIL						0.3V _{DD}	V
Input high voltage	VIH				0.7V _{DD}		V _{DD} +0.3	V
Output low voltage	V _{OL}	$I_{OL} = 100 \mu A$, $V_{DD} = V_{DD} min$				0.2	Ň	
		$I_{OL} = \overline{1.6mA, V_{DD} = V_{DD}} min$					0.4	v
Output high voltage	VOH	$I_{OH} = -100 \mu A$, $V_{DD} = V_{DD} min$			V _{CC} -0.2			V

Data hold, Rewriting frequency

Parameter	Conditions	min	max	unit
	Program/Erase	100,000		times/
Rewriting frequency	Status resister write	1,000		Sector
Data hold		20		year

Pin Capacitance at $Ta = 25^{\circ}C$, f = 1MHz

Deremeter	Symbol	Symbol	Ratings	unit
Farameter	Symbol	Conditions	max	unit
Output pin capacitance	C _{SO}	$V_{SO} = 0V$	12	pF
Input pin Capacitance	C _{IN}	$V_{IN} = 0V$	6	pF

Note: These parameter values do not represent the results of measurements undertaken for all devices but rather values for some of the sampled devices.

	Doromotor		Symbol	rmbol F			unit
			Symbol	min	typ	max	unit
	Read instr	Read instruction (03h)				33	MHz
Clock frequency All instruction		ions except for read (03h) ^I CLK			40	MHz
Input signal rising/falling	time		^t RF	0.1			V/ns
		33MHz		14			ns
SCK logic high level pulse width		40MHz	^I CLHI	11.5			ns
	a width	33MHz	4	14			ns
SCK logic low level puls	e width	40MHz	^I CLLO	11.5			ns
CS setup time			^t CSS	10			ns
CS hold time			^t CSH	10			ns
Data setup time			^t DS	5			ns
Data hold time			^t DH	5			ns
CS wait pulse width			^t CPH	25			ns
Output high impedance time from \overline{CS}			^t CHZ			15	ns
Output data time from S	CK		t _V		8	11	ns
Output data hold time			^t HO	1			ns
Output low impedance ti	me from SCK		^t CLZ	0			ns
WP setup time			tWPS	20			ns
WP hold time			tWPH	20			ns
HOLD setup time			^t HS	5			ns
HOLD hold time			tнн	5			ns
Output low impedance ti	me from HOL	5	^t HLZ			12	ns
Output high impedance	time from HOL	D	^t HHZ			9	ns
Power-down time			^t DP			5	μS
Power-down recovery tir	ne		^t PRB			500	μs
Write status register time		^t SRW		8	10	ms	
		256Byte			0.8	1.0	ms
Page programming cycle time nByte		nByte	^t PP		0.15+ n*0.65/256	0.20+ n*0.8/256	ms
Small sector erase cycle time		tSSE		0.04	0.15	S	
Sector erase cycle time			^t SE		0.08	0.25	S
Chip erase cycle time			^t CHE		0.5	6.0	S

AC Test Conditions

Input pulse level $\cdots 0.2V_{DD}$ to $0.8V_{DD}$ Input rising/falling time $\cdots 5ns$ Input timing level $\cdots 0.3V_{DD}$, $0.7V_{DD}$ Output timing level $\cdots 1/2 \times V_{DD}$ Output load $\cdots 15pF$

Note: As the test conditions for "typ", the measurements are conducted using 1.8V for VDD at room temperature.



Package Dimensions

unit : mm

VSOIC8 NB

CASE 753AA **ISSUE O**





RECOMMENDED **SOLDERING FOOTPRINT***



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS. 3. DIMENSION & DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.10mm IN EXCESS OF MAXIMUM MATERIAL CONDITION
- CONDITION. DIMENSION D DOES NOT INCLUDE MOLD FLASH, 4. DIMENSION D DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15mm PER SIDE. DIMENSION E DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25mm PER SIDE. DIMENSIONS D AND E ARE DETERMINED AT DATUMES A AND B ARE TO BE DETERMINED AT
- DATUMS A AND B ARE TO BE DETERMINED AT DATUM F. A1 IS DEFINED AS THE VERTICAL DISTANCE 5.
- 6. FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

I OINT ON THE INOING					
	MILLIMETERS				
DIM	MIN	MAX			
Α	0.65	0.85			
A1		0.05			
b	0.31	0.51			
С	0.17	0.25			
D	4.90 BSC				
E	6.00) BSC			
E1	3.90) BSC			
е	1.27 BSC				
L	0.40	1.27			
L2	0.25	5 BSC			

GENERIC **MARKING DIAGRAM***



XXXXX = Specific Device Code

- = Assembly Location
- = Wafer Lot

А L

Υ

W

- = Year
- = Work Week

= Pb-Free Package (Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present.

Figure 1 Pin Assignments



Table 1 Pin Description

Symbol	Pin Name	Description
SCK	Serial clock	This pin controls the data input/output timing.
		The input data and addresses are latched synchronized to the rising edge of the serial clock, and the data is
		output synchronized to the falling edge of the serial clock.
SI/SIO0	Serial data input	The data and addresses are input from this pin, and latched internally synchronized to the rising edge of the
	/ Serial data input output	serial clock. It changes into the output pin at Dual Output and it changes into the input output pin at Dual I/O.
SO/SIO1	Serial data input	The data stored inside the device is output from this pin synchronized to the falling edge of the serial clock. It
	/ Serial data input output	changes into the output pin at Dual Output and it changes into the input output pin at Dual I/O.
CS	Chip select	The device becomes active when the logic level of this pin is low; it is deselected and placed in standby status
		when the logic level of the pin is high.
WP	Write protect	The status register write protect (SRWP) takes effect when the logic level of this pin is low.
HOLD	Hold	Serial communication is suspended when the logic level of this pin is low.
V _{DD}	Power supply	This pin supplies the 1.65 to 1.95V supply voltage.
V _{SS}	Ground	This pin supplies the 0V supply voltage.

Figure 2 Block Diagram



Device Operation

The read, erase, program and other required functions of the device are executed through the command registers. The serial I/O corrugate is shown in Figure 3 and the command list is shown in Table 2. At the falling \overline{CS} edge the device is selected, and serial input is enabled for the commands, addresses, etc. These inputs are normalized in 8 bit units and taken into the device interior in synchronization with the rising edge of SCK, which causes the device to execute operation according to the command that is input.

The LE25S80FD supports both serial interface SPI mode 0 and SPI mode 3. At the falling \overline{CS} edge, SPI mode 0 is automatically selected if the logic level of SCK is low, and SPI mode 3 is automatically selected if the logic level of SCK is high.

Figure 3 I/O waveforms



Table 2 Command Settings

Command	1st bus cycle	2nd bus cycle	3rd bus cycle	4th bus cycle	5th bus cycle	6th bus cycle	Nth bus cycle
Read	03h	A23-A16	A15-A8	A7-A0	RD *1	RD *1	RD *1
High Speed Read	0Bh	A23-A16	A15-A8	A7-A0	Х	RD *1	RD *1
Dual Output Read	3Bh	A23-A16	A15-A8	A7-A0	Z	RD *1	RD *1
Dual I/O Read	BBh	A23-A8	A7-A0, X, Z	RD *1	RD *1	RD *1	RD *1
Small sector erase	20h / D7h	A23-A16	A15-A8	A7-A0			
Sector erase	D8h	A23-A16	A15-A8	A7-A0			
Chip erase	60h / C7h						
Page program	02h	A23-A16	A15-A8	A7-A0	PD *2	PD *2	PD *2
Write enable	06h						
Write disable	04h						
Power down	B9h						
Status register read	05h						
Status register write	01h	DATA					
JEDEC ID read	9Fh						
ID read	ABh	х	х	х			
power down	B9h						
Exit power down mode	ABh						

Explanatory notes for Table 2

"X" signifies "don't care" (that is to say, any value may be input).

The "h" following each code indicates that the number given is in hexadecimal notation.

Addresses A23 to A20 for all commands are "Don't care".

*1: "RD" stands for read data. *2: "PD" stands for page program data.

Table 3 Memory Organization 8M Bit

sector (64KB)	small sector (4KB)	address space (A23 to A0)		
	255	0FF000h	0FFFFh	
15	to			
	240	0F0000h	0F0FFFh	
	239	0EF000h	0EFFFFh	
14 to 6	То			
	96	060000h	060FFFh	
	95	05F000h	05FFFFh	
5	to			
	80	050000h	050FFFh	
	79	04F000h	04FFFFh	
4	to			
	64	040000h	040FFFh	
	63	03F000h	03FFFFh	
3	to			
	48	030000h	030FFFh	
	47	02F000h	02FFFFh	
2	to			
	32	020000h	020FFFh	
	31	01F000h	01FFFFh	
1	to			
	16	010000h	010FFFh	
	15	00F000h	00FFFFh	
0	to			
	2	002000h	002FFFh	
	1	001000h	001FFFh	
	0	000000h	000FFFh	

Description of Commands and Their Operations

A detailed description of the functions and operations corresponding to each command is presented below.

1. Standard SPI read

There are two read commands, the standard SPI read command and High-speed read command.

1-1. Read command

Consisting of the first through fourth bus cycles, the 4 bus cycle read command inputs the 24-bit addresses following (03h). The data is output from SO on the falling clock edge of fourth bus cycle bit 0 as a reference. "Figure 4-a Read" shows the timing waveforms.

Figure 4-a Read



1-2. High-speed read command

Consisting of the first through fifth bus cycles, the High-speed read command inputs the 24-bit addresses and 8 dummy bits following (0Bh). The data is output from SO using the falling clock edge of fifth bus cycle bit 0 as a reference. "Figure 4-b High-speed Read" shows the timing waveforms.



Figure 4-b High-speed Read

2. Dual read

There are two Dual read commands, the Dual Output read command and the Dual I/O read command. They achieve the twice speed-up from a High-speed read command.

2-1. Dual Output read command

The Dual Output read command changes SI/SIO0 into the output pin function in addition to SO/SIO1, makes the data output x2 bit and has achieved a high-speed output. Consisting of the first through fifth bus cycles, the Dual Output read command inputs the 24-bit addresses and 8 dummy bits following (3Bh). DATA1 (Bit7, BIt5, Bit3 and Bit1) is output from SI/SIO0 and DATA0 (Bit6, Bit4, Bit2 and Bit0) is output from SO/SIO1 on the falling clock edge of fifth bus cycle bit 0 as a reference. "Figure 5-a Dual Output read" shows the timing waveforms.

Figure 5-a Dual Output read



2-2. Dual I/O read command

The Dual I/O read command changes SI/SIO0 and SO/SIO1 into the input output pin function, makes the data input and output x2 bit and has achieved a high-speed output. Consisting of the first through third bus cycles, the Dual I/O read command inputs the 24-bit addresses and 4 dummy clocks following (BBh). The format of the address input and the dummy bit input is the x2 bit input. Add1 (A23, A21, -, A3 and A1) is input from S0/SIO1 and Add0 (A22, A20, -, A2 and A0) is input from SI/SIO0. 2CLK of the latter half of the dummy clock is in the state of high impedance, the controller can switch I/O for this period. DATA1 (Bit7, Bit5, Bit3 and Bit1) is output from SI/SIO0 and DATA0 (Bit6, Bit4, Bit2 and Bit0) is output from SO/SIO1 on the falling clock edge of third bus cycle bit 0 as a reference. "Figure 5-b Dual I/O Read" shows the timing waveforms.



Figure 5-b Dual I/O Read

When SCK is input continuously after the read command has been input and the data in the designated addresses has been output, the address is automatically incremented inside the device while SCK is being input, and the corresponding data is output in sequence. If the SCK input is continued after the internal address arrives at the highest address (FFFFFh), the internal address returns to the lowest address (00000h), and data output is continued. By setting the logic level of CS to high, the device is deselected, and the read cycle ends. While the device is deselected, the output pin SO is in a high-impedance state.

3. Status Registers

The status registers hold the operating and setting statuses inside the device, and this information can be read (Status Register read) and the protect information can be rewritten (Status Register write). There are 8 bits in total, and "Table 4 Status registers" gives the significance of each bit.

Bit	Name	Logic	Function	Power-on Time Information	
		0	Ready	<u>_</u>	
Bitu	RDY	1	Erase/Program	0	
Ditt		0	Write disabled		
Bit1	WEN	1	Write enabled	0	
Diao	DDO	0		No contactilo information	
Bit2	BP0	BP0 1		Nonvolatile information	
Diag		0 Block protect information		New relation information	
Bit3	BP1	1	Protecting area switch	Nonvolatile information	
Ditt	BB	0		New relation information	
Bit4	BP2	1		Nonvolatile information	
Disc	TD	0	Block protect		
BIto	Bit5 TB		Upper side/Lower side switch	Nonvolatile information	
Bit6			Reserved bits	0	
Bit7	0014/0	0	Status register write enabled		
	SRWP	SRWP 1		Status register write disabled	Nonvolatile information

Table 4 Status Registers

3-1. Status register read

The contents of the status registers can be read using the status register read command. This command can be executed even during the following operations.

- Small sector erase, sector erase, chip erase
- Page program
- Status register write

"Figure 6 Status Register Read" shows the timing waveforms of status register read. Consisting only of the first bus cycle, the status register command outputs the contents of the status registers synchronized to the falling edge of the clock (SCK) with which the eighth bit of (05h) has been input. In terms of the output sequence, SRWP (bit 7) is the first to be output, and each time one clock is input, all the other bits up to RDY (bit 0) are output in sequence, synchronized to the falling clock edge. If the clock input is continued after RDY (bit 0) has been output, the data is output by returning to the bit (SRWP) that was first output, after which the output is repeated for as long as the clock input is continued. The data can be read by the status register read command at any time (even during a program or erase cycle).

Figure 6 Status Register Read



3-2. Status register write

The information in status registers BP0, BP1, BP2, TB and SRWP can be rewritten using the status register write command. RDY, WEN and bit 6 are read-only bits and cannot be rewritten. The information in bits BP0, BP1, BP2, TB and SRWP is stored in the non-volatile memory, and when it is written in these bits, the contents are retained even at power-down. "Figure 7 Status Register Write" shows the timing waveforms of status register write, and Figure 20 shows a status register write flowchart. Consisting of the first and second bus cycles, the status register write command initiates the internal write operation at the rising CS edge after the data has been input following (01h). Erase and program are performed automatically inside the device by status register write so that erasing or other processing is unnecessary before executing the command. By the operation of this command, the information in bits BP0, BP1, BP2, TB and SRWP can be rewritten. Since bits RDY (bit 0), WEN (bit 1) and bit 6 of the status register cannot be written, no problem will arise if an attempt is made to set them to any value when rewriting the status register. Status register write ends can be detected by RDY of status register read. To initiate status register write, the logic level of the WP pin must be set high and status register WEN must be set to "1".

Figure 7 Status Register Write



3-3. Contents of each status register

RDY (Bit0)

The $\overline{\text{RDY}}$ register is for detecting the write (program, erase and status register write) end. When it is "1", the device is in a busy state, and when it is "0", it means that write is completed.

WEN (Bit1)

The WEN register is for detecting whether the device can perform write operations. If it is set to "0", the device will not perform the write operation even if the write command is input. If it is set to "1", the device can perform write operations in any area that is not block-protected.

WEN can be controlled using the write enable and write disable commands. By inputting the write enable command (06h), WEN can be set to "1"; by inputting the write disable command (04h), it can be set to "0." In the following states, WEN is automatically set to "0" in order to protect against unintentional writing.

- At power-on
- Upon completion of small sector erase, sector erase or chip erase
- Upon completion of page program
- Upon completion of status register write

* If a write operation has not been performed inside the LE25S80FD because, for instance, the command input for any of the write operations (small sector erase, sector erase, chip erase, page program, or status register write) has failed or a write operation has been performed for a protected address, WEN will retain the status established prior to the issue of the command concerned. Furthermore, its state will not be changed by a read operation.

BP0, BP1, BP2, TB (Bits 2, 3, 4, 5)

Block protect BP0, BP1, BP2 and TB are status register bits that can be rewritten, and the memory space to be protected can be set depending on these bits. For the setting conditions, refer to "Table 5 Protect level setting conditions". BP0, BP1, and BP2 are used to select the protected area and TB to allocate the protected area to the higher-order address area or lower-order address area.

	Status Register Bits				
Protect Level	ТВ	BP2	BP1	BP0	Protected Area
0 (Whole area unprotected)	х	0	0	0	None
T1 (Upper side 1/16 protected)	0	0	0	1	0FFFFFh to 0F0000h
T2 (Upper side 1/8 protected)	0	0	1	0	0FFFFFh to 0E0000h
T3 (Upper side 1/4 protected)	0	0	1	1	0FFFFFh to 0C0000h
T4 (Upper side 1/2 protected)	0	1	0	0	0FFFFFh to 080000h
B1 (Lower side 1/16 protected)	1	0	0	1	00FFFFh to 000000h
B2 (Lower side 1/8 protected)	1	0	1	0	01FFFFh to 000000h
B3 (Lower side 1/4 protected)	1	0	1	1	03FFFFh to 000000h
B4 (Lower side 1/2 protected)	1	1	0	0	07FFFFh to 000000h
5 (Whole area protected)	Х	1	0	1	0FFFFFh to 000000h
5 (Whole area protected)	x	1	1	Х	0FFFFFh to 000000h

* Chip erase is enabled only when the protect level is 0.

SRWP (bit 7)

Status register write protect SRWP is the bit for protecting the status registers, and its information can be rewritten. When SRWP is "1" and the logic level of the WP pin is low, the status register write command is ignored, and status registers BP0, BP1, BP2, TB and SRWP are protected. When the logic level of the WP pin is high, the status registers are not protected regardless of the SRWP state. The SRWP setting conditions are shown in "Table 6 SRWP setting conditions".

	Table	6 SRWP	Setting	Conditions
--	-------	--------	---------	------------

WP Pin	SRWP	Status Register Protect State
0	0	Unprotected
0	1	Protected
	0	Unprotected
1	1	Unprotected

Bit 6 are reserved bits, and have no significance.

4. Write Enable

Before performing any of the operations listed below, the device must be placed in the write enable state. Operation is the same as for setting status register WEN to "1", and the state is enabled by inputting the write enable command. "Figure 8 Write Enable" shows the timing waveforms when the write enable operation is performed. The write enable command consists only of the first bus cycle, and it is initiated by inputting (06h).

• Small sector erase, sector erase, chip erase

Figure 10 Power-down

- Page program
- Status register write

5. Write Disable

The write disable command sets status register WEN to "0" to prohibit unintentional writing. "Figure 9 Write Disable" shows the timing waveforms. The write disable command consists only of the first bus cycle, and it is initiated by inputting (04h). The write disable state (WEN "0") is exited by setting WEN to "1" using the write enable command (06h).



6. Power-down

The power-down command sets all the commands, with the exception of the silicon ID read command and the command to exit from power-down, to the acceptance prohibited state (power-down). "Figure 10 Power-down" shows the timing waveforms. The power-down command consists only of the first bus cycle, and it is initiated by inputting (B9h). However, a power-down command issued during an internal write operation will be ignored. The power-down state is exited using the power-down exit command (power-down is exited also when one bus cycle or more of the silicon ID read command (ABh) has been input). "Figure 11 Exiting from Power-down" shows the timing waveforms of the power-down exit command.



Figure 11 Exiting from Power-down

7. Small Sector Erase

Small sector erase is an operation that sets the memory cell data in any small sector to "1". A small sector consists of 4Kbytes. "Figure 12 Small Sector Erase" shows the timing waveforms, and Figure 21 shows a small sector erase flowchart. The small sector erase command consists of the first through fourth bus cycles, and it is initiated by inputting the 24-bit addresses following (20h) or (D7h). Addresses A19 to A12 are valid, and Addresses A23 to A20 are "don't care". After the command has been input, the internal erase operation starts from the rising CS edge, and it ends automatically by the control exercised by the internal timer. Erase end can also be detected using status register RDY.

Figure 12 Small Sector Erase



8. Sector Erase

Sector erase is an operation that sets the memory cell data in any sector to "1". A sector consists of 64Kbytes. "Figure 13 Sector Erase" shows the timing waveforms, and Figure 21 shows a sector erase flowchart. The sector erase command consists of the first through fourth bus cycles, and it is initiated by inputting the 24-bit addresses following (D8h). Addresses A19 to A16 are valid, and Addresses A23 to A20 are "don't care". After the command has been input, the internal erase operation starts from the rising \overline{CS} edge, and it ends automatically by the control exercised by the internal timer. Erase end can also be detected using status register \overline{RDY} .



Figure 13 Sector Erase

9. Chip Erase

Chip erase is an operation that sets the memory cell data in all the sectors to "1". "Figure 14 Chip Erase" shows the timing waveforms, and Figure 21 shows a chip erase flowchart. The chip erase command consists only of the first bus cycle, and it is initiated by inputting (60h) or (C7h). After the command has been input, the internal erase operation starts from the rising \overline{CS} edge, and it ends automatically by the control exercised by the internal timer. Erase end can also be detected using status register \overline{RDY} .

Figure 14 Chip Erase



10. Page Program

Page program is an operation that programs any number of bytes from 1 to 256 bytes within the same sector page (page addresses: A19 to A8). Before initiating page program, the data on the page concerned must be erased using small sector erase, sector erase, or chip erase. "Figure 15 Page Program" shows the page program timing waveforms, and Figure 22 shows a page program flowchart. After the falling CS, edge, the command (02H) is input followed by the 24-bit addresses. Addresses A19 to A0 are valid. The program data is then loaded at each rising clock edge until the rising CS edge, and data loading is continued until the rising CS edge. If the data loaded has exceeded 256 bytes, the 256 bytes loaded last are programmed. The program data must be loaded in 1-byte increments, and the program operation is not performed at the rising CS edge occurring at any other timing.



Figure 15 Page Program

11. ID Read

ID read is an operation that reads the manufacturer code and device ID information. The silicon ID read command is not accepted during writing. There are two methods of reading the silicon ID, each of which is assigned a device ID. In the first method, the read command sequence consists only of the first bus cycle in which (9Fh) is input. In the subsequent bus cycles, the manufacturer code 62h which is assigned by JEDEC, 2-byte device ID code (memory type, memory capacity), and reserved code are output sequentially. The 4-byte code is output repeatedly as long as clock inputs are present, "Table 7-1 JEDEC ID codes table" lists the silicon ID codes and "Figure 16-a JEDEC ID read" shows the JEDEC ID read timing waveforms.

The second method involves inputting the ID read command. This command consists of the first through fourth bus cycles, and the one bite silicon ID can be read when 24 dummy bits are input after (ABh). "Table 7-2 ID codes table" lists the silicon ID codes and "Figure 16-b ID read" shows the ID read timing waveforms.

If the SCK input persists after a device code is read, that device code continues to be output. The data output is transmitted starting at the falling edge of the clock for bit 0 in the fourth bus cycle and the silicon ID read sequence is finished by setting CS high.

		Output code
Manufacturer code		62h
2 byte device ID	Memory type	16h
	Memory capacity code	14h (8M Bit)
Device code	1	00h

Table 7-2 ID read	
-------------------	--

	Output Code	
1 byte device ID	86h (LE25S80FD)	
•		

Figure 16-a Silicon ID Read 1





No.A2260-16/23

12. Hold Function

Using the HOLD pin, the hold function suspends serial communication (it places it in the hold status). "Figure 17 \overline{HOLD} " shows the timing waveforms. The device is placed in the hold status at the falling \overline{HOLD} edge while the logic level of SCK is low, and it exits from the hold status at the rising \overline{HOLD} edge. When the logic level of SCK is high, \overline{HOLD} must not rise or fall. The hold function takes effect when the logic level of \overline{CS} is low, the hold status is exited and serial communication is reset at the rising \overline{CS} edge. In the hold status, the SO output is in the high-impedance state, and SI and SCK are "don't care".

Figure 17 HOLD



13. Power-on

In order to protect against unintentional writing, $\overline{\text{CS}}$ must be within at V_{DD}-0.3 to V_{DD}+0.3 on power-on. After power-on, the supply voltage has stabilized at V_{DD} min. or higher, waits for tPU before inputting the command to start a device operation. The device is in the standby state and not in the power-down state after power is turned on. To put the device into the power-down state, it is necessary to enter a power-down command.





14. Hardware Data Protection

LE25S80FD incorporates a power-on reset function. The following conditions must be met in order to ensure that the power reset circuit will operate stably.

No guarantees are given for data in the event of an instantaneous power failure occurring during the writing period.

Figure 19 Power-down Timing



Power-on timing

Devenueration	Symbol	spe		
Parameter		min	max	unit
power-on to operation time	t₽U	500		μs
power-down time	^t PD	10		ms
power-down voltage	VBOT		0.2	V

15. Software Data Protection

The LE25S80FD eliminates the possibility of unintentional operations by not recognizing commands under the following conditions.

- When a write command is input and the rising \overline{CS} edge timing is not in a bus cycle (8 CLK units of SCK)
- When the page program data is not in 1-byte increments
- When the status register write command is input for 2 bus cycles or more

16. Decoupling Capacitor

A 0.1μ F ceramic capacitor must be provided to each device and connected between V_{DD} and V_{SS} in order to ensure that the device will operate stably.

Timing waveforms

Serial Input Timing



Serial Output Timing



Hold Timing



Status register write Timing



Figure 20 Status Register Write Flowchart

Status register write



* Automatically placed in write disabled state at the end of the status register write

Figure 21 Erase Flowcharts



* Automatically placed in write disabled state at the end of the erase

state at the end of the erase

Figure 22 Page Program Flowchart



* Automatically placed in write disabled state at the end of the erase



* Automatically placed in write disabled state at the end of the programming operation.

LE25S80FD

Figure 23 Making Diagrams





YW

- = 1Pin Index Mark
- = Specific Device Code
- = Blank Data (entire memory cell data are FFh)
- = Assembly Location
- = Wafer Lot Traceability
- = Two Digits Year and Work Week Date coding

VSOIC8 NB, CASE 753AA (LE25S80FD)

ORDERING INFORMATION

Device	Package	Shipping (Qty / Packing)
LE25S80FDTWG	VSOIC8 NB, CASE 753AA (Pb-Free / Halogen Free)	3000 / Tape &Reel

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